

Evaluation of the Physical Properties of Secondary Battery Materials

Particle Size Distribution, Specific Surface Area/Pore Distribution Measurement

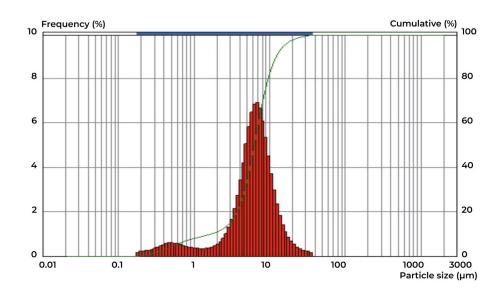
Example of particle size distribution measurement

Measurement of mixed samples yielded high-resolution and high-responsiveness data.

Sample: Lithium cobalt oxide + high-conductive carbon materials

Microtrac MT3300EX II Apparatus: Dispersion method: Dispersion medium: NMP

Ultrasound bath: 2 minutes

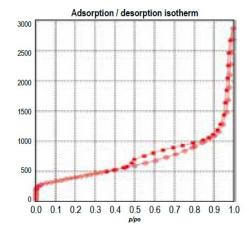


Example of electrode carrier evaluation

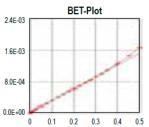
Evaluation of electrode carrier surface area for reduction of supported metal Evaluation of the aggregation status of primary particles

·Sample: High-conductive carbon material

·Apparatus: Automated Specific Surface Area/Pore Distribution Measurement System BELSORP-miniX



Start point 14 // End point 20 Gradient 2.9759E-03 Intercept 2.7467E-05 Correlation coefficient 0.9999 Vm [cm³ (STP) g-1] 332.96 as.BET [m²g⁻¹] 1.4492E+03 109.34 Total pore volume [cm³g-¹] 4.1828 (p/po=0.990)Mean pore diameter [nm] 11.545





Application

Particle size distribution measurement

- Cathode active materials Lithium cobalt oxide Lithium manganese oxide
- Conductive additives
 Acetylene black
 Carbon black
- Anode active materials
 Natural / synthetic graphite

Separator

Specific surface area / pore distribution, gas / steam adsorption measurement

- Evaluation of electrode catalyst carrier, reduction of supported metal
- Surface hydrophobicity / hydrophilicity evaluation
 Surface state
 Evenness / unevenness of surface state
- Differential adsorption heat evaluation
- Pore distribution / volume evaluation Nano-structure control

Apparatus

- Particle Size Distribution Measurement System Microtrac MT3000 II Series
 - Measuring principle: Laser diffraction/light scattering
 - Measuring range: 0.02-2800 μm
 - Line-up consisting of 4 types for different measuring ranges (upgrading possible)
 - Red three-beam semiconductor laser and unique detection mechanism
 - Smooth switching between wet and dry measuring modes by adoption of an outer cell design
 - Allows wet particle image analysis when combined with Microtrac PartAn SI



Specific surface area / Pore distribution measurement system BELSORP MINI X

- Measuring principle: Constant volume gas adsorption+ AFSM
- Measuring range: Specific surface area: 0.01 m²/g -
- Pore distribution: Diameter 0.7-500 nm (Optionally: Diameter 0.35-500 nm)
- Automated measurement of gas adsorption isotherm by the constant volume method, and measurement of specific surface area and pore distribution by the BET multi-point method.
- Adsorbed gas: N₂ and other non-corrosive gases
- Compact size, low price
- A pre-processor for adsorption measurement BELPREP VAC II / VAC III or BELPREP FLOW II is additionally needed.



For further information please contact us at:

www.microtrac.com